



Shenzhen Tuofeng Semiconductor Technology Co., Ltd

N-CHANNEL ENHANCEMENT MODE POWER MOSFET**TF3008****• General Description**

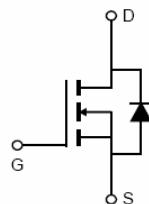
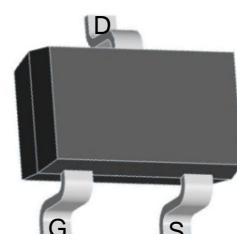
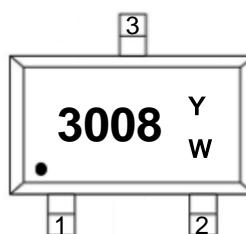
The TF3008 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- Load Switches
- Power management
- Battery protection
- BLDC Motor driver

• Product Summary $V_{DS}=30V \quad I_D=8.0A$ $R_{DS(ON)(10V\ typ)}=14.0m\Omega$ $R_{DS(ON)(4.5V\ typ)}=18.0m\Omega$ 

SOT23-3L

• Ordering Information:

Part NO.	TF3008
Marking1	3008:TF3008;
Marking2	Y:year; W:week
Basic ordering unit (pcs)	3000

• Absolute Maximum Ratings ($T_C = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_D @ T_C = 25^\circ C$	8.0	A
	$I_D @ T_C = 75^\circ C$	5.6	A
	$I_D @ T_C = 100^\circ C$	4.8	A
Pulsed Drain Current ^①	I_{DM}	24	A
Total Power Dissipation ^②	$P_D @ T_C = 25^\circ C$	1.2	W
Total Power Dissipation	$P_D @ T_A = 25^\circ C$	0.2	W
Operating Junction Temperature	T_J	-55 to 150	°C
Storage Temperature	T_{STG}	-55 to 150	°C



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•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case ^②	R _{thJC}	-	-	15	° C/W
Thermal resistance, junction - ambient	R _{thJA}	-	-	78	° C/W
Soldering temperature, wavesoldering for 8s	T _{sold}	-	-	265	° C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	30			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250uA	1.00	1.50	1.90	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} = 30V, V _{GS} =0V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 7.0A		14.0	17.0	mΩ
		V _{GS} = 4.5V, I _D = 5.0A		18.0	23.0	mΩ
Forward Transconductance	g _{FS}	V _{DS} = 10V, I _D = 5.0A		10		S
Source-drain voltage	V _{SD}	I _S = 7.0A		0.83	1.00	V

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C _{iss}	V _{DS} = 15V, V _{GS} =0V f = 1MHz	-	628	-	pF
Output capacitance	C _{oss}		-	88.7	-	
Reverse transfer capacitance	C _{rss}		-	72.5	-	

•Gate Charge characteristics(T_a = 25°C)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q _g	V _{DD} = 15V I _D = 7.0A V _{GS} = 10V	-	15.5	-	nC
Gate - Source charge	Q _{gs}		-	3.25	-	
Gate - Drain charge	Q _{gd}		-	2.14	-	

Note:

- ① Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% ;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

Typical Electrical and Thermal Characteristics

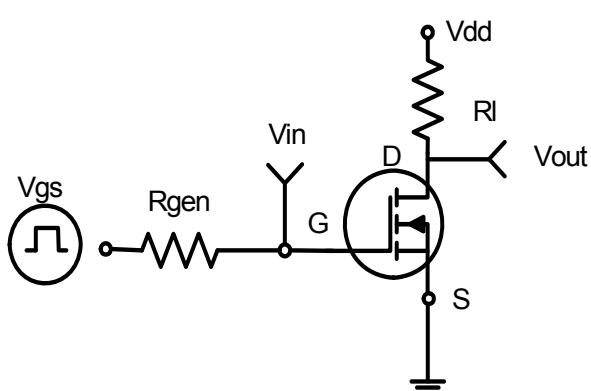


Figure 1 Switching Test Circuit

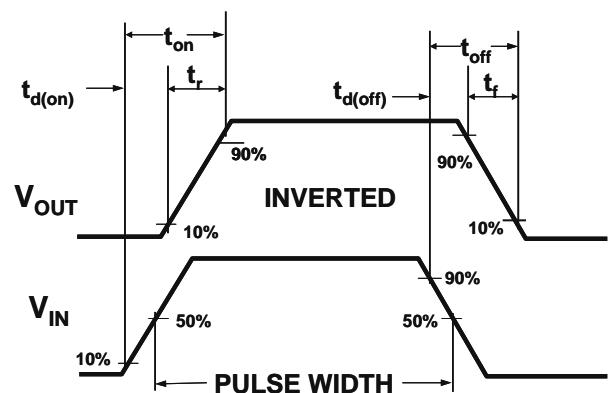


Figure 2 Switching Waveforms

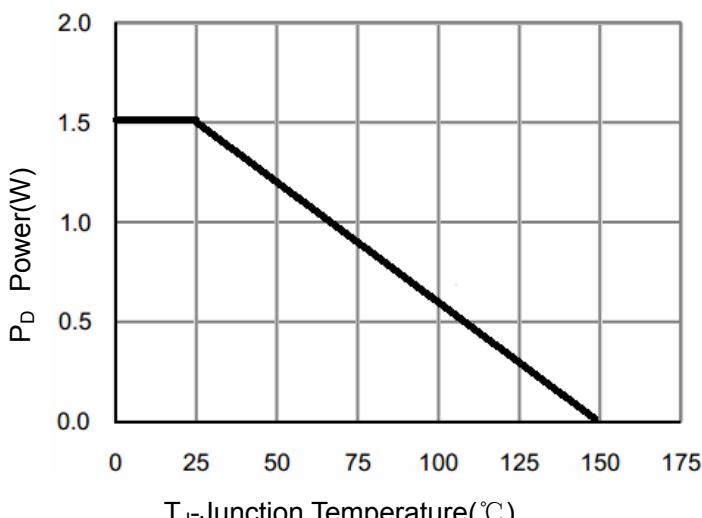


Figure 3 Power Dissipation

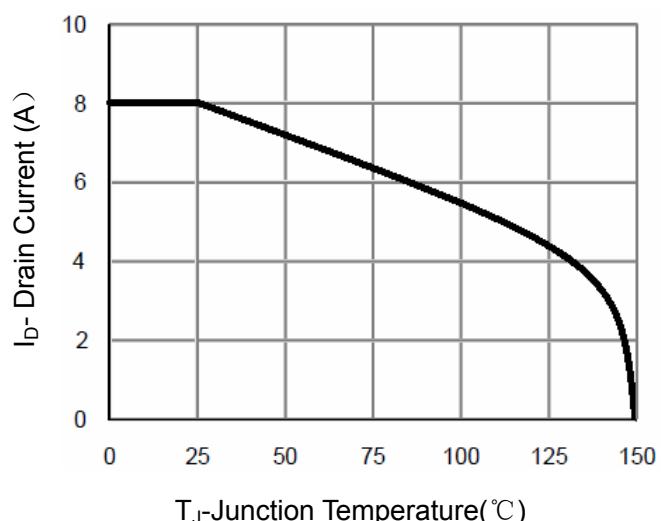


Figure 4 Drain Current

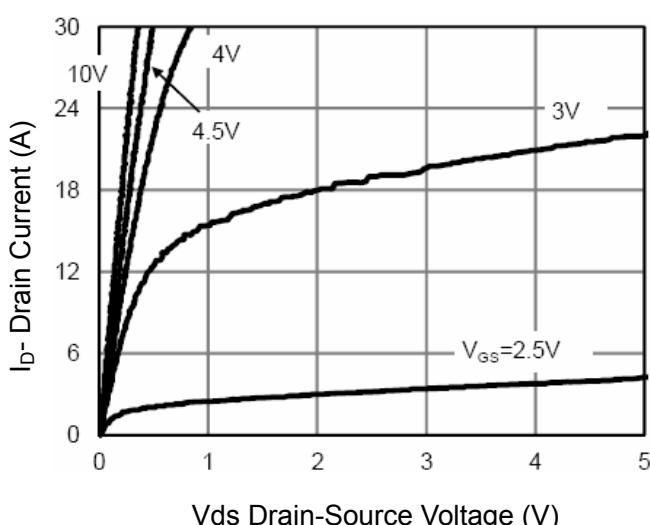


Figure 5 Output Characteristics

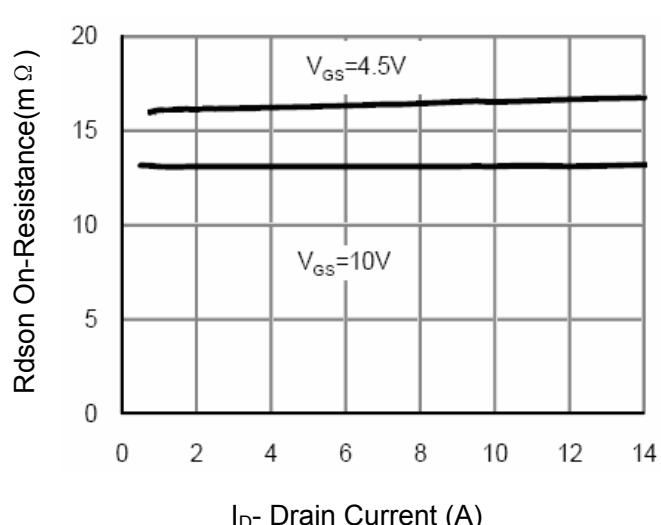


Figure 6 Drain-Source On-Resistance

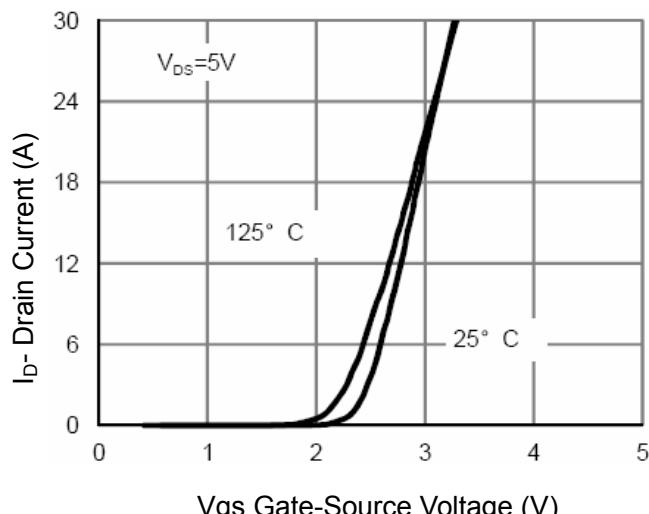


Figure 7 Transfer Characteristics

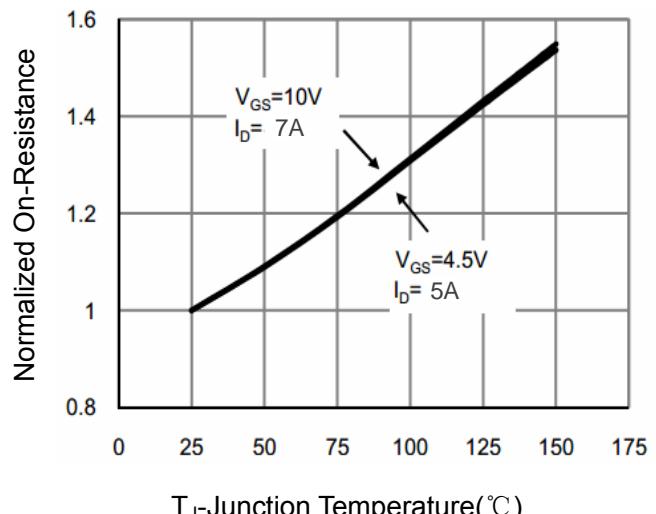


Figure 8 Drain-Source On-Resistance

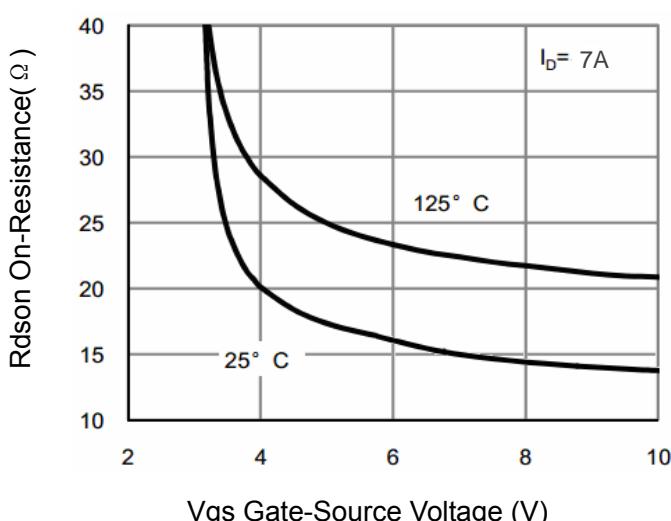


Figure 9 $R_{DS(on)}$ vs V_{GS}

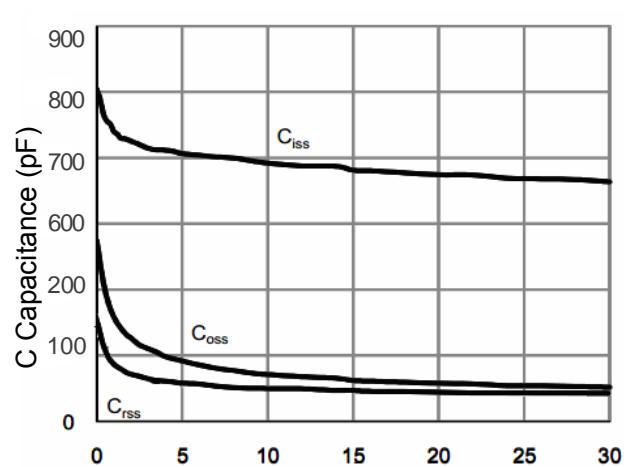


Figure 10 Capacitance vs V_{DS}

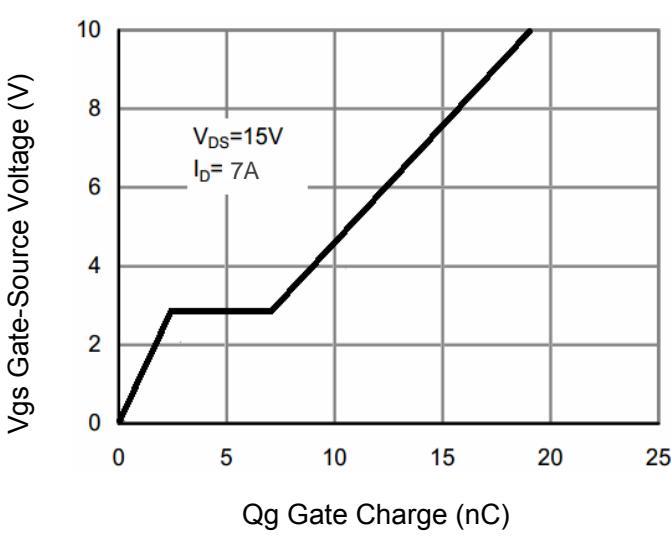


Figure 11 Gate Charge

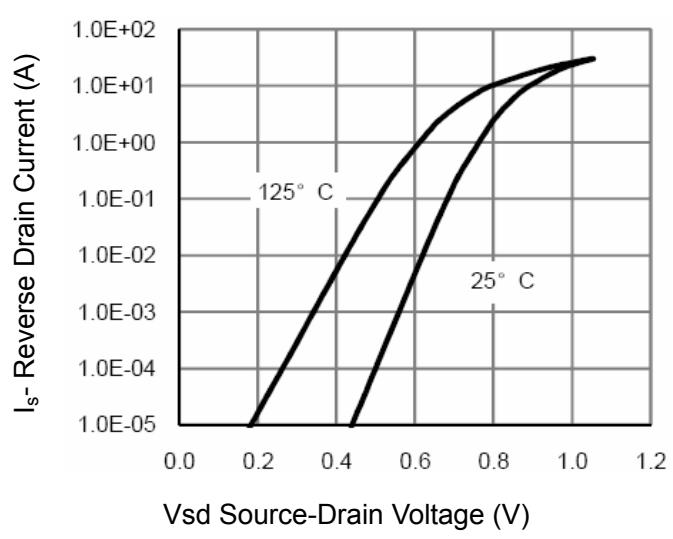
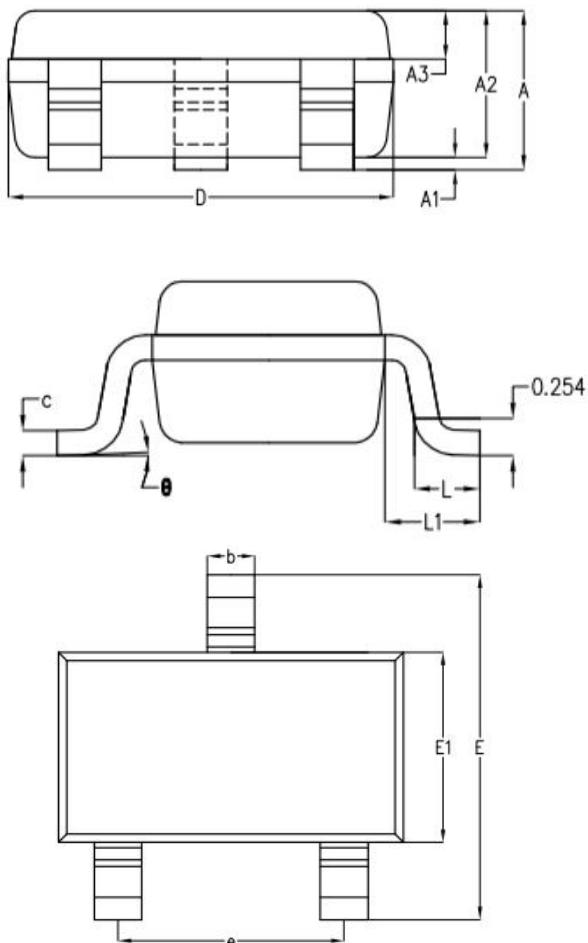


Figure 12 Source- Drain Diode Forward

SOT23-3L



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	-	1.19	1.24
A1	-	0.05	0.09
A2	1.05	1.10	1.15
A3	0.31	0.36	0.41
b	0.35	0.40	0.45
c	0.12	0.17	0.22
D	2.85	2.90	2.95
E	2.80	2.90	3.00
E1	1.55	1.60	1.65
e	1.90BSC		
L	0.37	0.45	0.53
L1	0.65BSC		
θ	0°	2°	8°